

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10840053	BEDEKAR ET AL.
	Examiner	Art Unit
	Shaq Taha	2446

SEARCHED

Class	Subclass	Date	Examiner
709	227, 228, 249	9/27/2007	S. Taha
709	227, 228, 249	04/06/2008	S. Taha
709	249	12/08/2008	S. Taha
709	249	08/05/2009	S. Taha
709	249	03/18/2010	S. Taha
709	249	09/17/2010	S. Taha

SEARCH NOTES

Search Notes	Date	Examiner
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see attached; NPL: IEEE; Inventor Search/DP; Text search in cls 709, and Google Patent.	9/27/2007	S. Taha
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see attached; NPL: IEEE; Inventor Search/DP; Text search in cls 709, and Google Patent.	04/06/2008	S. Taha
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see attached; NPL: IEEE; Inventor Search/DP; Text search in cls 709/227,228,229	12/08/2008	S. Taha
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see attached; NPL: IEEE; Inventor Search/DP; Text search in cls 709/227,228,229	08/05/2009	S. Taha
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see attached; NPL: IEEE; Inventor Search/DP; Text search in cls 709/227,228,229	03/18/2010	S. Taha
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see attached; NPL: IEEE; Inventor Search/DP; Text search in cls 709/227,228,229	09/17/2010	S. Taha

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner